

Application/	Control	No.	

Applicant(s)/Patent under Reexamination

10/802,001 Examiner

George R. Evanisko

KIM ET AL.
Art Unit
3762

SEARCHED					
Class	Subclass	Date	Examiner		
607	25				
600	508-510				
600	515, 516,				
600	51 9-521	11/26/2006			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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